


<b>Search Notes</b>  	<b>Application/Control No.</b>  10817611	<b>Applicant(s)/Patent Under Reexamination</b>  SUN ET AL.
	<b>Examiner</b>  Alain L Bashore	<b>Art Unit</b>  1792

SEARCHED			
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SEARCH NOTES		
Search Notes	Date	Examiner
previous search updated	8-31-08	ab
EAST (attached)	8-31-08	ab

INTERFERENCE SEARCH			
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	/Alain L Bashore/ Primary Examiner.Art Unit 1792
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